

2N5210

NPN EPITAXIAL SILICON TRANSISTOR

T-29-21

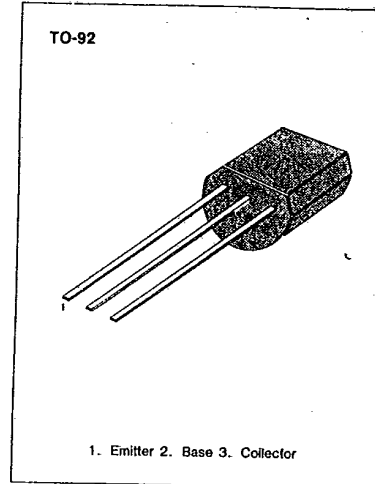
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CE0} = 50V$
- Collector Dissipation: $P_C (max) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	4.5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

* Refer to 2N5088 for graphs



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ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1mA, I_B = 0$	50			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 35V, I_E = 0$			50	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 3V, I_C = 0$			50	nA
DC Current Gain	h_{FE}	$I_C = 100\mu A, V_{CE} = 5V$	200		600	
		$I_C = 1mA, V_{CE} = 5V$	250			
		$I_C = 10mA, V_{CE} = 5V$	250			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10mA, I_B = 1mA$			0.7	V
Base-Emitter On Voltage	$V_{BE(on)}$	$I_C = 1mA, V_{CE} = 5V$			0.85	V
Current Gain Bandwidth Product	f_T	$I_C = 500\mu A, V_{CE} = 5V$	30			MHz
		$f = 20MHz$				
Collector Base Capacitance	C_{cb}	$V_{CB} = 5V, I_E = 0$			4	pF
		$f = 100KHz$				
Noise Figure	NF	$I_C = 20\mu A, V_{CE} = 5V$			2	dB
		$R_S = 22K\Omega$				
		$f = 10Hz$ to $15.7KHz$				
		$I_C = 20\mu A, V_{CE} = 5V$			3	dB
		$R_S = 10K\Omega, f = 1KHz$				

* Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$